

Integrated Device Technology, Inc. 2975 Stender Way, Santa Clara, CA - 95054

PRODUCT/PROCESS CHANGE NOTICE (PCN)

PCN #: SM-0504-	-03	DATE: April 6,	2005	MEANS OF DIST	INGUISHING CHANG	ED DEVICES:		
Product Affected: BF/BFG 100 (Refer Attachment II for the affected part numbers)			 Product Mark Back Mark Date Code 					
Date Effective:	May 2, 2005			_	Change in unit quantity p	ber tray		
Title:	Mary Vesey Quality Assurance M (831)-754- 4565	anager		Attachment::	Yes	🗌 No		
	(831)-754-4672			Samples:	N/A			
E-mail:	<u>mary.vesey@idt.co</u>	<u>m</u>						
DESCRIPTION A	AND PURPOSE OF	CHANGE:						
 Die Technology Wafer Fabrication Process Assembly Process Equipment Material To change new revision of tray with different tray matrix for BF/BFG100. Tray is compliant to JEDEC 95 Standards. Tray size (outside dimensions) will remain the same. New revision of tray provides better pick & place process on equipment.								
□ Testing		Description	Cu	rrent Tray	New Tray]		
□ Manufacturing	Site	IDT Drawing# :		C-1703	MSC-1776			
Data SheetOther		Quantity Per Tray : Pocket Size :		units 1m x 10mm	240 units 10mm x 10 mm			
		Tray Matrix :		x 25	10 x 24			
CUSTOMER AC IDT records indic to grant approval it will be assumed IDT reserves the	CKNOWLEDGMEN ate that you require w or request additional d that this change is a	vritten notification of th information. If IDT doe cceptable. rsion manufactured afte	is chang s not re	ceive acknowledge	cknowledgement below of ment within 30 days of t ive date until the invento	his notice		
Customer:				Approval for	shipments prior to	effective date.		
Name/Date:			E-N	fail Address:				
Title:			Pho	ne# /Fax# :				
CUSTOMER CO	DMMENTS:							
IDT ACKNOWL	EDGMENT OF RE	CEIPT:						
RECD. BY:				DATE:		_		
IDT FRA-1509-01 REV. 00 09/18/01 Page 1 o				of 1	Re	efer To QCA-1795		



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ATTACHMENT I - PCN: SM-0504-03

Qual Plan : BC4-07-01

Test Vehicle :10 mm x10 mm Shipping Tray

Qualification Test Plan and Result:		
Description	Evaluation Result	Status
A. PACKAGING MATERIAL QUAL		
 i) Package Fit in Pocket Test – Place a unit in a tray pocket. Rejects if a) Any lead or solder ball touches any part of the tray (wall or platform). Note : Not applicable to VFQPF-N packages. b) Unit NOT sitting firmly in pocket and movement > 20 mils on left to right or top to bottom. 	ОК	Done
 ii) Tray Interface Check - Complete fill the tray pockets with units and places a cover tray on top. Strap the trays with Velcro Strap and vigorously shake the stack in a live and dead bug position 30 times. Remove the straps and cover tray. Reject if : a) Any damages to the units or package dislodged from its pockets. b) Any scratches on the package (included surface scratches) 	ОК	Done
 iii) Complete fill the tray pockets with units and tilt the units in the pocket into slanting position Reject if : a) Any contact between top cover tray with units. b) Any scratches or chip on the package. 	ОК	Done
 iv) Complete fill the tray pockets with units and places a cover tray on top. Press the top cover tray until contact with the bottom tray. Then remove the top cover tray properly. Reject if: a) The bottom tray sticks with top cover tray. b) Any unit sticks to the bottom pocket of top cover tray. 	ОК	Done
 v) Chip or crack test – Drop tray on 4 sides, top and bottom from a distance of 20 inches on a concrete floor. Reject if any chips and cracks on the trays. 	ОК	Done
vi) Unit shall not drop out from the tray pocket during machine placement or transportation	OK	Done
vii) Tray shall be free of foreign particles, wet or oily build-up, or any types of contamination	OK	Done
viii) Fresh tray from supplier shall be free of chips and crack	OK	Done
ix) Tray shall be no pits or scratches greater than 40 mils on length or 20 mils in depth that would impact the normal use of the tray	ОК	Done
x) Incomplete fill of any part of the tray shall not more than 100 mils maximum in any direction.	OK	Done
xi) Incomplete fill of any part of the tray shall not more than 100 mils maximum in any direction.	OK	Done
kii) For tray pocket fences, 75% of the fences length should be with at least 75% of the fence's height.	ОК	Done
xiii) Tray shall meet IDT (Assembly, Test and Backend area) equipment input and output tooling	ОК	Done
xiv) Pass Static Electricity Test (100 volt max)	OK	Done
xv) Surface Resistively reading (between 1x105 to 1x1011 ohms per sq.)	OK	Done
xvi) Must pass IDT bake test.	ОК	Done
xvii) Must pass Standard Drop Test a) 3-fts drop test (For BGA and substrate only) b) 6-fts drop test	Height : 3fts (normal packing) 30x Inspection : 924/924 Observation : no abnormality. Height : 6fts (normal packing) Inspection result: 924/924 30x Inspection : 924/924 Observation : no abnormality	Done
xviii) Tray must be flip-able design.	OK	Done
B. COPLAN		
Lead/ Ball Inspection Machine	Machine buy-off result :- - M/c : CI-9450 - Jam Rate : 0/720 - P&P : 0/720 - UPH : 8640	Done



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ATTACHMENT II - PCN: SM-0504-03

Affected Part Number:

IDT Part No	IDT Part No	IDT Part No
IDT709159L6BF	IDT70T34L20BF	IDT70V9159L7BFI
IDT709159L7BF	IDT70T34L25BF	IDT70V9159L9BF
IDT709159L7BFI	IDT70T34L25BFI	IDT70V9159L9BFI
IDT709159L9BF	IDT70T35L20BF	IDT70V9169L6BF
IDT709159L9BFI	IDT70T35L25BF	IDT70V9169L7BF
IDT709169L6BF	IDT70T35L25BFI	IDT70V9169L7BFI
IDT709169L7BF	IDT70T9159L12BF	IDT70V9169L9BF
IDT709169L7BFI	IDT70T9159L12BFI	IDT70V9169L9BFI
IDT709169L9BF	IDT70T9159L7BF	IDT70V9349L6BF
IDT709169L9BFI	IDT70T9159L9BF	IDT70V9349L7BF
IDT709349L6BF	IDT70T9159L9BFI	IDT70V9349L7BFI
IDT709349L7BF	IDT70T9169L12BF	IDT70V9349L9BF
IDT709349L7BFI	IDT70T9169L12BFI	IDT70V9349L9BFI
IDT709349L9BF	IDT70T9169L7BF	IDT70V9359L6BF
IDT709349L9BFI	IDT70T9169L9BF	IDT70V9359L7BF
IDT709359L6BF	IDT70T9169L9BFI	IDT70V9359L7BFI
IDT709359L7BF	IDT70T9349L12BF	IDT70V9359L9BF
IDT709359L7BFI	IDT70T9349L12BFI	IDT70V9359L9BFI
IDT709359L9BF	IDT70T9349L7BF	
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IDT70T06L25BF	IDT70T9359L9BF	
IDT70T06L25BFI	IDT70T9359L9BFI	
IDT70T15L20BF	IDT70V24L15BF	
IDT70T15L25BF	IDT70V24L20BF	
IDT70T15L25BFI	IDT70V24L20BFI	
IDT70T16L20BF	IDT70V24L25BF	
IDT70T16L25BF	IDT70V24L55BF	
IDT70T16L25BFI	IDT70V24VL55BF	
IDT70T24L20BF	IDT70V24VL55BFI	
IDT70T24L25BF	IDT70V25L15BF	
IDT70T24L25BFI	IDT70V25L20BF	
IDT70T25L20BF	IDT70V25L25BF	
IDT70T25L25BF	IDT70V9159L6BF	
IDT70T25L25BFI	IDT70V9159L7BF	



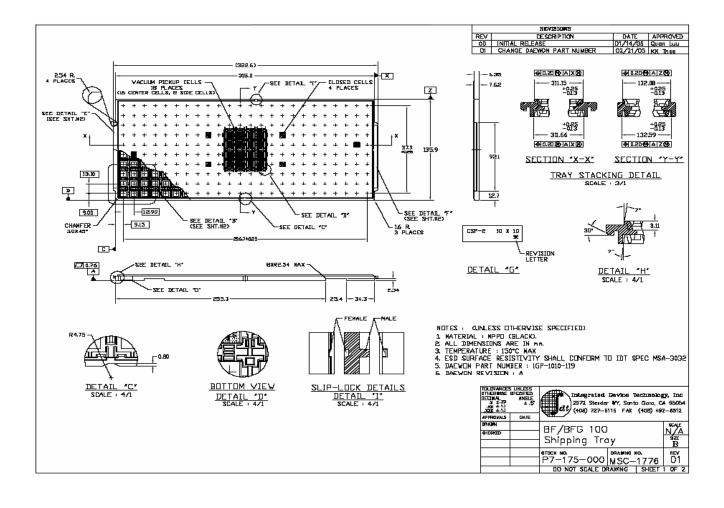
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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT III - PCN: SM-0504-03

TRAY DRAWING I





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ATTACHMENT III - PCN: SM-0504-03

TRAY DRAWING II

